Application/Control No. Applicant(s)/Patent Under Reexamination 10/713,709 FANG ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Kin-Chan Chen 1765 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY * US-2002/0086908 07-2002 Chou et al. Α 516/98 * US-2003/0060555 03-2003 В Lorah et al. 524/445 US-2004/0216388 11-2004 Mathur et al. С 051/298 * D US-5,026,421 06-1991 Le Loarer et al. 106/3 * US-2004/0220317 11-2004 Lorah et al. Ε 524/445

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